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Rapid hybrid chemical vapor deposition for efficient and hysteresis-free perovskite solar modules with an operation lifetime exceeding 800 hours†

Longbin Qiu,[‡] Sisi He,[‡] Zonghao Liu,[‡] Luis K. Ono,[‡] Dae-Yong Son, Yuqiang Liu, Guoqing Tong and Yabing Qi^{*}

Hybrid chemical vapor deposition (HCVD) has been employed in the fabrication of perovskite solar cells (PSCs) and modules (PSMs), and it shows strong promise for upscalable fabrication. The conventional HCVD process needs a relatively long processing time (e.g., several hours) and the fabricated PSCs often exhibit salient hysteresis, which impedes utilization of this technology for mass production. Herein, we demonstrate a rapid HCVD (RHCVD) fabrication process for PSCs using a rapid thermal process, which not only significantly reduces the deposition time to less than 10 min, but also effectively suppresses hysteresis. This markedly reduced deposition time is comparable to that of solution-coating processes. Furthermore, the shorter processing time inside the furnace reduces the exposure time of the glass/ITO/SnO₂ substrates under vacuum, which helps maintain the high quality of the SnO₂ electron-transport layer and results in a lower density of gap states. Finally, PSMs with a designated area of 22.4 cm² fabricated via RHCVD achieved an efficiency of 12.3%, and maintained 90% of the initial value after operation under continuous light illumination for over 800 h.

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Introduction

Perovskite, as a low-cost material, has boosted the performance up to 25.2% for small area (0.09 cm²) single-junction solar cells¹ and the expected leveled cost of electricity (LCOE) is as low as 3.5 US cents per kW h (for comparison, the LCOE for grid power is 7.04–11.90 US cents per kW h and for c-Si solar cells it is 9.78–19.33 US cents per kW h) when assuming a 1 m² module with 20% efficiency and >15 years lifetime,^{2,3} and this exceeds the 2030 goals of the US Department of Energy of 5 US cents per kW h for residential solar power.⁴ Recently, there has been more and more work focused on upscalable fabrication of perovskite solar modules (PSMs) to transfer the desired performance from small area cells to large-area modules.⁵ However, there is still a large gap between small area cells and large-area modules.⁵ To achieve upscalable fabrication, a key indicator is the performance decay rate upon upscaling. For mature photovoltaic technologies (e.g., crystalline silicon solar cells, polycrystalline silicon solar cells, CdTe solar cells), the absolute performance decay rate is around 0.8% per decade of the area increase.^{6,7} If

the same decay rate can be realized for perovskite photovoltaic technologies, a power conversion efficiency (PCE) of approximately 22% would be expected for a module with an area of approximately 1000 cm² when scaling up from the state of the art small area cells (25.2% PCE with a cell area of 0.0937 cm²).⁶ Currently the highest reported PCE for such a large-size PSM is 17.9% with a designated area of 804 cm².¹ To reduce the large PCE gap between small area cells and large-area modules, upscalable fabrication methods for the perovskite and other functional layers (e.g., electron transport layer (ETL), hole transport layer (HTL), electrode and interface modification) are required.⁵ For the upscalable fabrication of perovskite solar cells (PSCs), both solution- and vapor-based processes have been reported, including doctor blading,^{8,9} slot-die coating,¹⁰ spray coating,¹¹ thermal evaporation¹² and hybrid chemical vapor deposition (HCVD).^{5,13,14}

HCVD is a promising method as compared to the solution-based ones because of its advantages, such as uniform deposition across large areas, low cost, solvent-free, and readiness for integration with other thin film solar technologies (e.g., thin film silicon solar cells) to form tandem solar cells.¹³ Currently, the decay rate between small area solar cells and large area solar modules upon upscaling is 1.3% per decade of the area increase,¹⁵ which is approaching other mature photovoltaic technologies. HCVD is a two-step deposition process. In the first step, inorganic precursor materials (e.g., PbI₂, PbCl₂, CsI, etc.)

Energy Materials and Surface Sciences Unit (EMSSU), Okinawa Institute of Science and Technology Graduate University (OIST), 1919-1 Tancha, Kunigami-gun, Onna-son, Okinawa 904-0495, Japan. E-mail: Yabing.Qi@OIST.jp

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‡ L. Qiu and S. He contributed equally to this work.



are deposited by thermal evaporation,¹⁴ spray coating¹³ or spin coating.¹⁶ In the second step, organic precursor materials (e.g., FAI, MAI, MABr, etc., where FA is formamidinium and MA is methylammonium) are sublimed in the first heating zone of a CVD tube furnace, and subsequently driven by a gas flow (e.g., dry N₂, Ar, or dry air) towards the second heating zone, where the organic precursor vapor reacts with the inorganic precursor that is pre-deposited on the substrate, leading to perovskite film growth.^{14,15} Based on the pressure and heating zone temperatures, a variety of HCVD techniques can be developed to fabricate perovskite films, including atmospheric pressure HCVD,^{16–18} low-pressure HCVD,¹⁴ single-zone HCVD^{19,20} and double-zone HCVD.¹⁴ However, all of the HCVD processes usually need a relatively long processing time (2–3 hours), which severely limits their mass-production capabilities for solar cell fabrication. Reducing the deposition time is still a challenge that needs to be fully addressed for the further development of the module-scale HCVD technique. Furthermore, it has been found that the long deposition time has a detrimental effect on the ETL, such as SnO₂ or TiO₂, which deteriorates the solar module performance.¹⁵ Also, hysteresis was observed due to the un-optimized interface between this ETL layer and the perovskite layer. Incorporation of an additional buffer layer such as C₆₀ improves the HCVD processed solar cell performance by reducing the negative impact of vacuum annealing on the ETL.¹⁵ However, this additional layer increases the cost and complexity of the deposition process.

Herein, we report a rapid HCVD (RHCVD) process to fabricate PSCs and PSMs (Fig. 1). The RHCVD process greatly reduces the deposition time from several hours to within 10 min, which is comparable with typical solution coating processes. As compared with the regular HCVD process, the RHCVD processed PSCs exhibits only slight hysteresis even without any additional interfacial buffer layer. Using RHCVD, we obtained an efficiency of 15.5% for the small-area PSC (active area = 0.1 cm²). Furthermore, we show that the RHCVD process is readily upscalable for fabricating PSMs, the area of which is only limited by the size of the CVD tube furnace. As a demonstration, we fabricated PSMs on 5 cm by 5 cm substrates with a designated area of 22.4 cm² and a geometric fill factor of approximately 90%. The performance of the PSMs was up to 12.3% with almost no hysteresis. The 224 times increase in the device area with an absolute PCE reduction of 3.2% (i.e., a decay rate of 1.36% per decade of the area increase), further confirms the upscalability of this RHCVD method. The operational lifetime of the encapsulated PSMs was tested under continuous light illumination with a steady voltage output (the initial maximum power point (MPP) voltage) and the PSM maintained 90% of its initial performance after operation for more than 800 h.

Results and discussion

In this work, we used an n-i-p planar PSC structure with the perovskite layer sandwiched between the ETL and HTL, which is a simple structure without the mesoporous structures.²¹ This structure also eliminates the high-temperature step needed to

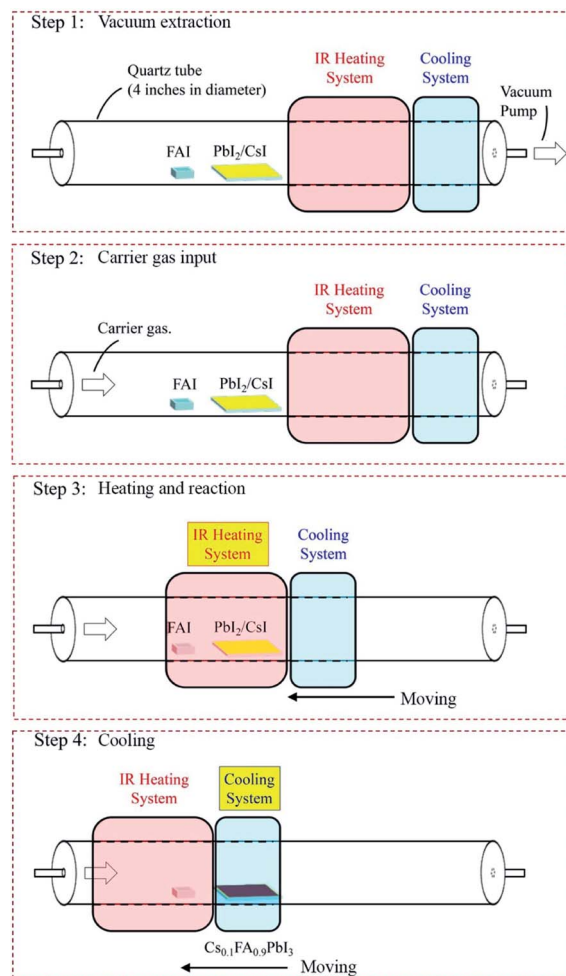


Fig. 1 Schematic illustrations showing the steps and major features for fabricating perovskite films via the RHCVD method. Step 1: the loading of a crucible containing the organic compound and solar module substrate(s) with the pre-coated inorganic layer into a single-zone quartz tube. Step 2: flowing of the carrier gas (e.g., dry N₂, Ar, air, etc.), keeping the vacuum at a pressure of 10 Torr. Step 3: sliding the IR heating system to enclose both the organic powder and substrate and followed by the starting the IR heating system. Step 4: after the heating process is finished, the IR heating system is turned off and the cooling system is turned on. The cooling system is slid to the substrate position.

process mesoporous structures, which helps reduce cost. Fig. 2a displays the structure of the PSC with the configuration of ITO/SnO₂/perovskite/spiro-MeOTAD/Au, in which the perovskite layer is deposited by RHCVD with a composition of Cs_{0.1}FA_{0.9}PbI₃. A small amount of Cs cations is added to improve the phase stability of FAPbI₃.^{22,23} Similar to the regular HCVD process, the RHCVD process is a two-step process with the first step consisting of co-evaporation of CsI and PbI₂ by optimizing the deposition rates to realize the desired composition.^{5,15} In the second step, the substrates pre-coated with the mixture film of CsI and PbI₂ are placed in a CVD tube furnace to react with FAI to form perovskite. On the basis of the temperature profile (for the heating zone containing the substrates) as a function of time shown in Fig. 2b, in a regular HCVD process the total



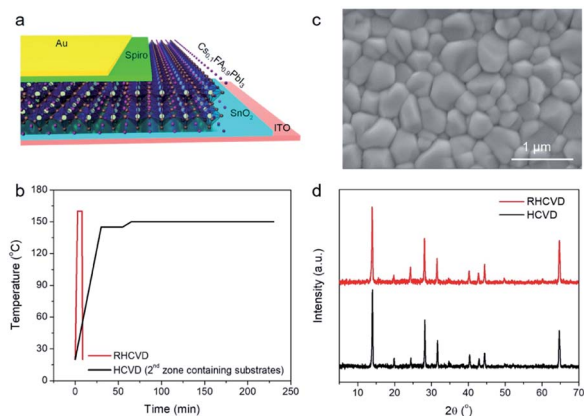


Fig. 2 (a) A schematic drawing showing the PSC structure. (b) The programmed temperature profile as a function of time during RHCVD and the regular HCVD process for the heating zone containing the substrates. (c) SEM micrograph of the perovskite film prepared by RHCVD. (d) XRD patterns of the perovskite films prepared by RHCVD and regular HCVD.

deposition time of FAI is approximately 230 min (the temperature ramping time is 65 min and the deposition time is 160 min, with about 5 min of cooling down when the furnace cap is opened to speed up dropping of the temperature to below 100 °C) to ensure the complete conversion of PbI_2 to perovskite.^{15,19,20} The temperature profile for the heating zone containing the organic precursor is shown in Fig. S1†. The temperature ramping rate is slow, *e.g.*, 2.3 °C min⁻¹ to obtain stable ramping for a relatively low annealing temperature. Setting higher ramping rates (*e.g.*, 5 °C min⁻¹) can lead to uncontrollable temperature fluctuations. For example, when a fast temperature ramping is used, the actual temperature in the CVD tube can reach much higher temperatures than the programmed temperature (Fig. S2†), which may lead to damage of the perovskite layer. We developed a single zone RHCVD process using a rapid-thermal annealing (RTA) tube furnace. The RTA tube furnace uses an infrared (IR) heating component to achieve ultrafast temperature ramping. The IR heating component is mechanically movable along the furnace tube, which enables fast heating and cooling. The RHCVD process for the deposition of perovskite is less than 10 min (Fig. 2b). Detailed steps of the RHCVD process for the deposition of perovskite films are depicted in Fig. 1. Although a similar process was reported previously for the growth of graphene,²⁴ our work is the first report to apply this process for the fabrication of PSCs.

The as-deposited $\text{Cs}_{0.1}\text{FA}_{0.9}\text{PbI}_3$ film shows a smooth surface and grain sizes in the range of 300–500 nm (Fig. 2c). SEM micrographs confirm the good uniformity of the surface morphology of the RHCVD deposited perovskite films across a relatively large area (20 μm × 13 μm) (Fig. S3†). The XRD result confirms the full conversion of PbI_2 to perovskite, as there is a strong peak at 14.0° and no observable peak at 12.7° (Fig. 2d). The smooth baseline and the absence of the peak at around 11.6° indicate that the formed perovskite film is mainly pure α-phase. High resolution Cs 3d core-level X-ray photoelectron

spectroscopy (XPS) data verify the incorporation of Cs cations into the perovskite (Fig. S4†), which agrees well with our previous study on the $\text{Cs}_{0.1}\text{FA}_{0.9}\text{PbI}_{2.9}\text{Br}_{0.1}$ perovskite film prepared by the regular HCVD method.¹⁵ The composition ratio between Cs and Pb is determined by XPS to be approximately 1 : 10, which agrees well with the desired ratio. Our previous studies suggest that iodide (I^-) can easily desorb from iodide-based perovskite films leading to generation of iodine (I_2) gas under vacuum conditions and subsequently being pumped out.^{25,26} During the HCVD or RHCVD processes, the large amount of the organic precursor FAI in the crucible (0.1 g) provides sufficient supply of I^- , minimizing the deterioration of the perovskite films during the RHCVD process. Furthermore, the fact that perovskite films prepared by RHCVD show high quality and uniformity over a large area (even without additional annealing as compared to most solution processed perovskite films) indicates that RHCVD is an efficient way to form perovskite films, possibly thanks to the dual function of IR heating in promoting perovskite formation, as well as uniformly heating the converted perovskite films to enhance the film crystallinity. The electronic structures of the deposited perovskite $\text{Cs}_{0.1}\text{FA}_{0.9}\text{PbI}_3$ film has been further investigated by UPS (Fig. S5†). The deposited perovskite showed an n-type nature with a work function of 3.92 eV and valence band maximum of 1.50 eV below the Fermi level. The absorbance of the perovskite film has been characterized by UV-vis absorption measurements and the optical band gap of 1.56 eV is determined on the basis of the Tauc-plot (Fig. S6†).

Our solar cells are based on the perovskite films deposited by RHCVD and the SnO_2 ETL. In our previous work, the SnO_2 ETL was fabricated by sputtering at room temperature.²⁷ The crystallinity of the sputtered SnO_2 films was studied as a function of the post-annealing temperature in the range of 100–500 °C. The room temperature deposited SnO_2 film showed an amorphous structure, and the crystallinity was only observed after post-annealing at temperatures over 300 °C.²⁷ However, the post-annealing process also deteriorated the quality of the SnO_2 films.²⁷ Similar to the reports of Park and coworkers, annealing of the amorphous SnO_2 ETL at 500 °C crystallizes SnO_2 . However, the enhanced crystallinity reduces the device performance and leads to large hysteresis, due to the increased interface capacitance.²⁸ Furthermore, the vacuum annealing process during the regular HCVD process not only damages the deposited SnO_2 films, but also increases the density of gap states located between the valence band and Fermi level, which might further decrease the performance of the as-prepared solar cell devices.¹⁵ On the other hand, the solution processed films using SnO_2 nanocrystal solutions exhibit a higher quality compared with sputtered amorphous SnO_2 films after a similar vacuum annealing process in a CVD tube furnace.¹⁵ In this work, we performed a detailed study to investigate the influence of the sputtered amorphous SnO_2 (*i.e.*, without post-annealing to avoid damage) and solution-processed SnO_2 films on the PSC device performance.^{29,30} First, a nanocrystal SnO_2 layer was prepared by spin coating, or alternatively, an amorphous SnO_2 layer was prepared by sputter coating on the ITO/glass substrates. The surface morphology of the SnO_2 film was first



characterized by atomic force microscopy (AFM). As can be seen in Fig. S7,† the solution processed nanocrystal SnO_2 film shows a smoother morphology compared with the sputtered SnO_2 film. The surface roughness (RMS) for the sputtered SnO_2 and solution coated nanocrystal SnO_2 films is 2.79 and 0.88 nm, respectively (Fig. S7†). The RMS of the sputtered amorphous SnO_2 layer is similar to that of the ITO substrate (2.45 nm) due to a conformal coating, while the SnO_2 nanocrystals help reduce the surface roughness of the substrate.²⁷

The PCE for the PSC device based on the spin coated SnO_2 nanocrystal ETL is 15.0% in the reverse scan and 14.1% in the forward scan (Fig. S8†). Comparing the PCEs from the reverse scans, the PSC devices have negligible differences based on solution coated SnO_2 and sputter deposited SnO_2 . However, the PSC devices with a sputter-deposited SnO_2 ETL showed 7 times

higher hysteresis index (0.06 *versus* 0.41; hysteresis index = $(\text{PCE}_{\text{reverse}} - \text{PCE}_{\text{forward}})/\text{PCE}_{\text{reverse}}$) and 57.4% lower forward scan efficiency. The severe hysteresis issue in the PSC devices can be attributed to the sputtered SnO_2 ETL that has a combination of an amorphous structure, high surface roughness and a large defect density.^{27–29} Hence, we selected solution coated SnO_2 nanocrystal films as the ETL to fabricate subsequent PSC devices.

We have further studied the advantages of RHCVD compared with the regular HCVD process. The most significant advantage is the much shorter deposition time thanks to the rapid thermal process. RHCVD can lead to increased throughput and hence lower cost. It also helps reduce the vacuum annealing effect on the SnO_2 ETL.¹⁵ Fig. 3a compares the representative J - V curves for the PSC devices fabricated based on RHCVD and regular HCVD. Similar to our previous study, the longer vacuum annealing process in the regular HCVD process deteriorates the quality of the SnO_2 ETL, and the PSC device performance is much lower. The photovoltaic parameters are summarized in Table 1. For RHCVD, the champion PSC device shows a PCE of 15.5%. In contrast, for regular HCVD, the PCE is only approximately 7.6%. Although the addition of a thin layer of C_{60} and formation of a $\text{SnO}_2/\text{C}_{60}$ double-layer ETL could help improve the PSC performance as reported in our previous work,¹⁵ this additional step of vacuum deposition of C_{60} will increase the complexity of the fabrication and increase the LCOE. For RHCVD, because the high-quality of the SnO_2 ETL is maintained during the much shorter vacuum annealing process, the PSC device performance is much higher. PSC devices fabricated *via* a regular HCVD process show a lower current density, and the incident-photon-to-current-efficiency (IPCE) spectra (Fig. 3b) confirm the results obtained from the J - V curves (Table 1). The current density of the PSC fabricated by the RHCVD process was determined to be 22.3 mA cm^{-2} from the J - V curve and 21.2 mA cm^{-2} from the EQE curve (4.93% difference), and the current density of the PSC fabricated by regular HCVD was determined to be 18.8 mA cm^{-2} from the J - V curve and 18.0 mA cm^{-2} from the EQE curve (4.26% difference). Although these differences are not negligible, they are within a relatively low level (*i.e.*, below 5% of the current density) (see Table S1†), which suggests that our measurements were reasonably accurate.³¹ The optical properties of the SnO_2 films after the RHCVD process and the regular HCVD process have been characterized (Fig. S9†). As shown in Fig. S9,† the transmittances of both SnO_2

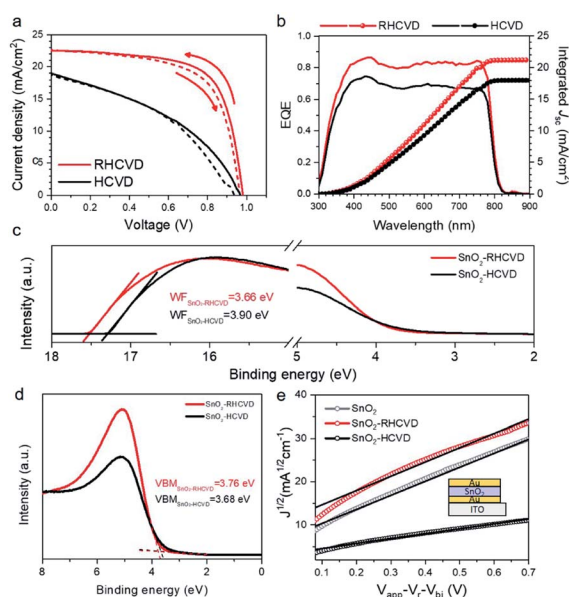


Fig. 3 (a) J - V curves of the champion PSCs based on RHCVD and the regular HCVD process with forward and reverse scans. (b) IPCE spectra of the champion PSCs based on RHCVD and the regular HCVD process. (c) UPS spectra of the SnO_2 films treated *via* the RHCVD process and the regular HCVD process. (d) Enlarged UPS valence features of the SnO_2 films based on the RHCVD process and the regular HCVD process. (e) Electron mobilities for the as-prepared SnO_2 film, and the SnO_2 film after the RHCVD process and the regular HCVD process using the SCLC method. The device structure of ITO/Au/ SnO_2 /Au is shown as the inset.

Table 1 Photovoltaic parameters for PSCs fabricated using the RHCVD process and the regular HCVD process

		Scan direction	V_{OC} (V)	J_{SC} (mA cm^{-2})	FF (%)	PCE (%)
RHCVD	Champion	Reverse	0.99	22.3	70.2	15.5
		Forward	0.97	22.6	64.5	14.1
	Average	Reverse	0.98 ± 0.01	22.2 ± 0.4	65.8 ± 3.5	14.3 ± 0.8
		Forward	0.96 ± 0.02	22.3 ± 0.4	63.9 ± 1.9	13.9 ± 0.6
Regular HCVD	Champion	Reverse	0.96	19.0	42.1	7.6
		Forward	0.93	18.8	40.0	7.0
	Average	Reverse	0.91 ± 0.05	17.5 ± 1.0	43.9 ± 1.4	7.0 ± 0.3
		Forward	0.93 ± 0.04	17.5 ± 1.2	42.4 ± 1.7	6.8 ± 0.3



films on a quartz substrate are similar to each other, and the optical band gap of both films determined based on the Tauc-plot is 3.85 eV. This large band gap is expected to show a deep valence band and suitable hole blocking properties.

We further studied the defect density of the SnO₂ films that experienced different vacuum annealing processes to understand their influence on the PSC device performance. Ultraviolet photoemission spectroscopy (UPS) and XPS measurements were carried out to characterize the surface properties of the SnO₂ films after the vacuum annealing process. To understand the surface properties, SnO₂ films coated on ITO substrates were placed into the CVD tube furnace to simulate the vacuum annealing process during RHCVD and regular HCVD. No organic precursors were loaded into the CVD furnace for the study on the effects of temperature and vacuum conditions. As shown in Fig. 3c, the SnO₂ film that experienced the RHCVD vacuum annealing process shows a lower work function (WF) of 3.66 eV, while for the SnO₂ film that experienced the regular HCVD vacuum annealing process the WF is much higher (3.90 eV). As for the ETL layer, a lower WF is expected to better facilitate electron extraction.^{32,33} This explains why the PSC devices based on the SnO₂ ETL that experienced long vacuum annealing showed poorer performance. The gap state density between the valence band minimum and the Fermi level also increases for the longer vacuum annealing process (Fig. 3c).¹⁵ The enlarged UPS valence features (Fig. 3d) and high resolution XPS valence features (Fig. S10†) further confirm the increased gap states between the valence band and the Fermi level. These gap states lower the hole blocking barrier and increase recombination, hence lowering the V_{OC} and the PCE of the PSCs.²⁷ We used the space-charge limited-current (SCLC) technique to characterize the electronic properties of the devices based on the symmetric sandwich structure (see the inset in Fig. 3e). The mobility was calculated using the Mott–Gurney law.³⁴ The mobility for the freshly coated SnO₂ film was $5.0 \times 10^{-4} \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$. After the shorter vacuum annealing process (10 min) to simulate the RHCVD process, the mobility of the SnO₂ film became $5.1 \times 10^{-4} \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$, which was almost the same as before. However, the mobility for the SnO₂ film that experienced a longer vacuum annealing process of 230 min showed a much lower mobility of $1.7 \times 10^{-4} \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$, which is likely the result of the increased gap states acting as scattering/trapping centers. These observations strongly suggest that RHCVD not only significantly reduces the deposition time, but also maintains the high quality of the SnO₂ nanocrystal ETL, which is the main reason for the improvement of PCE up to 15.5%.

To help understand the main reason responsible for the current density reduction, we studied the energy level alignment based on perovskite and SnO₂ for the case of RHCVD *versus* regular HCVD (Fig. S11†). Similar to the previous reports on planar PSCs based on the SnO₂ and TiO₂ ETL, the energy level mismatch at the perovskite/TiO₂ interface prevents efficient charge extraction and therefore leads to reduced current density.^{35–39} Here in this work, the conduction band of the SnO₂ film that experienced the regular HCVD process shows an upward shift, and the work function also increases by 0.24 eV. There is an energy barrier for electron extraction from the

perovskite film to SnO₂. For the SnO₂ film that experienced the RHCVD process, the energy level alignment between the perovskite and SnO₂ is better (Fig. S11†). The low work function helps facilitate electron extraction. Furthermore, with a longer vacuum annealing during the regular HCVD process, more gap states are formed above the valence band of the SnO₂ film, which lowers the hole blocking properties of this interface and increases charge carrier recombination (Fig. S11†).²⁷

To further verify that vacuum annealing deteriorates charge carrier extraction and increases charge carrier recombination, we fabricated PSCs based on solution-coated perovskite films deposited on a SnO₂ ETL with and without vacuum annealing, and the results are shown in Fig. S12.† As we can see, the PSC device based on the SnO₂ ETL film after a long time of vacuum annealing shows lower performance with reduced open circuit voltage, short circuit current density and fill factor, which agrees with our previous results.¹⁵ On the other hand, the PSC device based on the SnO₂ ETL film after a short time of vacuum annealing as in the RHCVD process does not show much difference between the control sample case and the RHCVD-treated SnO₂ case. The faster carrier extraction from the perovskite film to the SnO₂ ETL after the RHCVD process is further verified by the time resolved photoluminescence (TRPL) spectra (Fig. S13 and Table S2†). The resulting curves are fitted by a double exponential model with fast and slow decay time constants (τ_1 and τ_2).³⁶ The fast decay time constant τ_1 corresponds to the quenching of charge carriers by electron extraction from CH₃NH₃PbI₃ to SnO₂.²⁷ With the reduced vacuum annealing process time, the fast time constant τ_1 decreased from 17.8 ns for CH₃NH₃PbI₃ on SnO₂-HCVD to 10.9 ns for CH₃NH₃PbI₃ on SnO₂-RHCVD. This observation also implies that a longer vacuum annealing process may increase the gap states and deteriorate the quality of the SnO₂ layer.

In the case of regular HCVD, the combination of mismatched energy levels between the SnO₂ ETL and the perovskite film, increased gap states in the SnO₂ ETL, and reduced mobility of the SnO₂ film contributed to the decreased solar cell performance. The major differences between the regular HCVD and RHCVD are summarized in Table 2.

The balance between the temperature ramping time, deposition time and perovskite layer thickness has been studied to further optimize the RHCVD process. Higher temperatures can shorten the deposition time. However, the deposition rate of FAI and the reaction between deposited FAI and PbI₂ need to be balanced. If FAI is deposited faster than its reaction with PbI₂, there will be excess FAI on top of the perovskite film. When FAI is deposited substantially slower than its reaction with PbI₂, the feeding of FAI will be the time limiting factor and a longer time is needed for the complete conversion of PbI₂ to perovskite. The optimized condition for RHCVD corresponds to a balanced condition required for vaporization of FAI, diffusion into PbI₂ and reaction with PbI₂.^{15,40} Upon temperature increase, both the FAI deposition rate and the reaction rate with PbI₂ increase. As the temperature increased to 170 °C (RHCVD-2 in Fig. 4a), the device performance started to decrease (Fig. 4b), which indicates a faster increase of the FAI deposition rate compared with its reaction rate with PbI₂, and a pale surface on the top of the



Table 2 The major differences between a previous work (*J. Mater. Chem. A*, 2019, 7, 6920–6929) and the current work

	<i>J. Mater. Chem. A</i> , 2019, 7, 6920–6929	This work
Deposition time	A total of 230 min (including ramping, deposition, and cooling)	Less than 10 min with a rapid ramping and deposition process
The heating component	In the regular HCVD process, the tube furnace is heated by resistive heating (<i>i.e.</i> , using filaments); the ramping of the temperature is slow and temperature fluctuation is large	For the RHCVD process, we use a rapid thermal annealing tube furnace, which uses an infrared (IR) heating component with stable control of temperature. The IR heating component is mechanically movable along the furnace tube, which enables fast heating and cooling. This is the first report to apply this rapid thermal annealing process for the fabrication of PSCs and PSMs
ETL structure	The SnO ₂ ETL was deposited by a sputtering process at room temperature and it is amorphous in structure. Due to the prolonged vacuum annealing process, the SnO ₂ quality has been reduced with increased gap states. A thin layer of C ₆₀ has been incorporated to maintain the electron extraction and transport properties. However, this complicated the deposition process with one more vacuum deposition step	In this work, the SnO ₂ ETL was prepared using a solution of SnO ₂ nanocrystals
Hysteresis and device performance	Due to the prolonged vacuum annealing process and induced gap states in the SnO ₂ ETL, the solar cells and modules showed hysteresis. And a module with a 22.4 cm ² designated area showed a PCE of 10%, and that with a 91.8 cm ² designated area showed a PCE of 9.34%	In the case of RHCVD, the solar cells and modules showed substantially reduced hysteresis with high-quality SnO ₂ . PSMs with a designated area of 22.4 cm ² showed a PCE of 12.3%
Operational stability	The <i>T</i> ₈₀ lifetime is around 500 h	The <i>T</i> ₉₀ lifetime is over 800 h. The much better operation stability is most likely due to the higher quality of the SnO ₂ ETL, <i>i.e.</i> , the new RHCVD method leads to a lower density of gap states in the SnO ₂ ETL

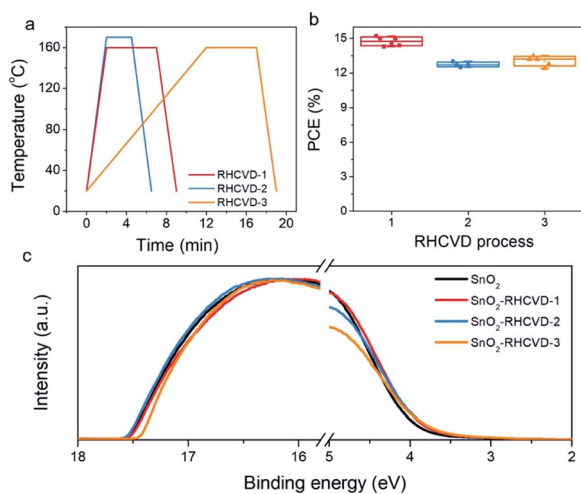


Fig. 4 (a) Temperature profiles as a function of time during different RHCVD processes. The RHCVD-2 process has a higher temperature and a shorter treatment time compared with the RHCVD-1 process. The RHCVD-3 process has a slower ramping rate during the temperature increase step compared with the RHCVD-1 process. (b) The dependence of PCE on the different RHCVD processes. (c) UPS spectra of the SnO₂ films treated with different RHCVD processes.

perovskite film was observed after being taken out from the tube. On the other hand, with a slower ramping rate (RHCVD-3 in Fig. 4a), the total vacuum annealing time will increase, and

the WF of the SnO₂ ETL prepared from the SnO₂ nanocrystal rises slightly (Fig. 4c). Based on these observation, a shorter reaction time and higher ramping rate benefit the formation of high-quality perovskite films and SnO₂ film. The thickness of the PbI₂ film also influences the deposition time because a thicker PbI₂ film would need more FAI for the conversion to perovskite. To ensure sufficient light absorbance, a film thickness of 370 nm for the perovskite was chosen in this work (Fig. S14†).⁵

HCVD is promising for upscalable fabrication of PSCs. 10 cm × 10 cm PSMs have been demonstrated for the regular HCVD process and the upscaling of the size from 0.1 cm² to 91.8 cm² shows a small absolute PCE decay rate of 1.3% per decade of the area increase.¹⁵ Similarly, in this work we also tested upscalable capability of RHCVD. Here the CVD tube furnace used for the RHCVD process has an inner diameter of 96 mm, which is the only limitation for the size of the substrates to be used. We fabricated a PSM on a 5 cm × 5 cm substrate using the RHCVD process. The PSM has a designated area of 22.4 cm² with 7 cells connected in series. For each subcell the ITO stripe width is 6.6 mm, and there is a 0.1 mm P1 patterning line between each sub stripe. The length of each sub-cell is 4.8 cm, with 1 mm space at the edges that are perpendicular to the patterning lines. The edges that are parallel to the patterning line have a space of 1.5 mm and are used for wiring of the electrodes (Fig. S15†). The typical



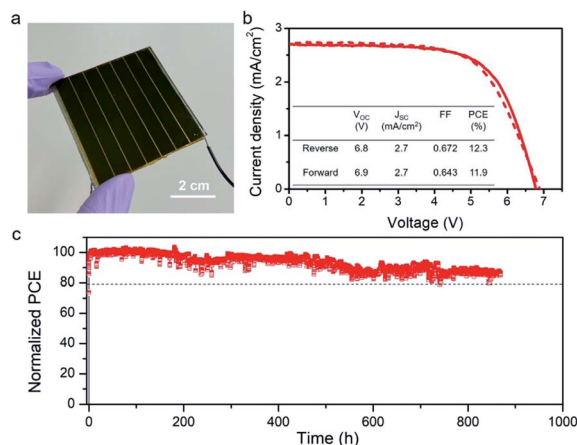


Fig. 5 PSMs fabricated via the RHCVD process. (a) A photograph of a 5 cm \times 5 cm PSM. (b) A forward scan and reverse scan from the PSM with the best performance of 12.3%. (c) The continuous operation of PSMs under continuous light illumination.

geometric fill factor for the module is approximately 90%.^{15,27} The champion PSM has a PCE of 12.3% and almost no hysteresis (Fig. 5a and b). Furthermore, the continuous operation of the PSM under continuous light illumination in a dry N₂ box was measured by recording the PSM power output under a steady voltage output, which corresponded to the initial maximum power point voltage. As shown in Fig. 5c, the power output of the PSM maintained 90% of its initial value after continuous working under light illumination after 800 h. The RHCVD process shows a significantly shorter processing time and longer operation stability and is a promising method for upscalable fabrication of PSMs with larger areas, smaller PCE decay and longer operational lifetime (Table S3†).

Experimental

Materials

All the commercial materials were used as received without further purification, including SnO₂ (Alfa Aesar, tin(IV) oxide, 15% in H₂O colloidal dispersion), PbI₂ (99.99%, TCI), CsI (99.99% Sigma), formamidinium iodide (FAI, greatcell solar), isopropanol (Wako), and 2,2',7,7'-tetrakis(*N,N*-di-*p*-methoxyphenylamine)-9,9'-spirobifluorene (spiro-MeOTAD, Merck).

Solar cell device fabrication

Indium-doped tin oxide (ITO) substrates were washed with distilled water, acetone and isopropanol in sequence, and dried with N₂ gas. Before the usage of the ITO substrates, they were pre-treated under UV/O₃ for 30 min. The SnO₂ layer was coated on the ITO surface by spin coating of the SnO₂ nanocrystal solution (2.5% in distilled water) at 3000 rpm for 30 s, followed by drying at 150 °C for 30 min. The perovskite precursor layer was deposited by a thermal co-evaporation process of PbI₂ and CsI, which was reported in our previous work.¹⁵ Here the evaporation rate of PbI₂ and CsI was controlled to be 0.10 nm

s⁻¹ and 0.01 nm s⁻¹, respectively. Then the PbI₂/CsI-coated substrate was transferred to a single-zone tube or a multi-zone tube furnace to conduct the RHCVD process or the regular HCVD process. After reaction and cooling, the resultant perovskite film was washed with IPA solution, followed by heating at 100 °C for 20 min to remove the residual FAI on the surface of the perovskite. A hole transport material solution was spin-coated on top of the perovskite layer at the rotation speed of 3000 rpm for 30 s. The hole transport material solution contained 29 mg of spiro-MeOTAD, 11.5 μ L of TBP and 7 μ L of Li-TFSI solution in 0.4 mL chlorobenzene. Finally, a layer of 100 nm thickness of gold was evaporated as the back-contact electrode. For module fabrication, the Au electrode thickness was 120 nm.

RHCVD

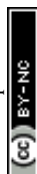
Detailed steps of the RHCVD process for the deposition of perovskite films are depicted in Fig. 1. In brief, the RHCVD process is performed in a single-zone tube furnace with FAI powder as the precursor. At one end of the tube furnace a vacuum pump is connected, and at the other end a vacuum gauge is connected and controls the vacuum level of the furnace to 10 Torr. During the RHCVD process, a sufficient amount of FAI powder (0.1 g) is placed in the upstream zone of the furnace close to the pre-deposited CsI/PbI₂ substrate. After the reaction, the furnace is moved and the heating zone is cooled with a fan to accelerate the cooling speed of the tube.

Characterization

Surface morphology was observed using an SEM (FEI Quanta 250 FEG). The UPS and XPS spectra were recorded using an XPS-AXIS Ultra HAS (Kratos) with monochromatic Al-K α = 1486.6 eV and non-monochromatic He-I α = 21.22 eV sources. The crystal structure of the perovskite was analysed using XRD (Bruker D8 Discover). *J*-*V* curves of the solar cells were measured using a Keithley 2420 Source Meter under AM1.5 illumination generated from a solar simulator (Oriel-Sol3A). The illumination intensity of 100 mW cm⁻² was adjusted by using a reference silicon solar cell before the measurements of the PSCs and PSMs.

Conclusions

In this work, we report a RHCVD method, which can help maintain a high-quality SnO₂ ETL and enable the deposition of high-quality perovskite layers. The significant reduction in the processing time from several hours to less than 10 minutes can substantially increase the perovskite solar cell production throughput. After optimization of the various parameters for the RHCVD fabrication (*e.g.*, process temperature, perovskite layer thickness, SnO₂ ETL, *etc.*), we obtained PSCs with PCEs up to 15.5% and PSMs with a PCE of 12.3%. The fabrication of PSMs shows the upscalable capabilities of this RHCVD method. Furthermore, the fabricated PSM shows a high operational stability and maintains 90% of its initial PCE value after 800 hours of continuous operation under light illumination.



Conflicts of interest

Yabing Qi, Longbin Qiu, Sisi He, and Luis K. Ono are named inventors on the patent application 63036068 (filing date: June 8, 2020), which is related to the techniques described in this article.

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